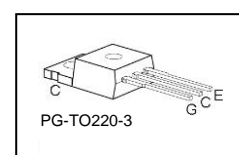
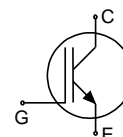


Low Loss IGBT : IGBT in TRENCHSTOP™ and Fieldstop technology



### Features:

- Very low  $V_{CE(sat)}$  1.5V (typ.)
- Maximum Junction Temperature 175°C
- Short circuit withstand time 5 $\mu$ s
- Designed for :
  - Frequency Converters
  - Uninterrupted Power Supply
- TRENCHSTOP™ and Fieldstop technology for 600V applications offers :
  - very tight parameter distribution
  - high ruggedness, temperature stable behavior
  - very high switching speed
- Positive temperature coefficient in  $V_{CE(sat)}$
- Low EMI
- Pb-free lead plating; RoHS compliant
- Qualified according to JEDEC<sup>1</sup> for target applications
- Complete product spectrum and PSpice Models : <http://www.infineon.com/igbt/>



| Type      | $V_{CE}$ | $I_C$ | $V_{CE(sat), T_j=25^\circ C}$ | $T_{j,max}$ | Marking Code | Package    |
|-----------|----------|-------|-------------------------------|-------------|--------------|------------|
| IGP15N60T | 600V     | 15A   | 1.5V                          | 175°C       | G15T60       | PG-TO220-3 |

### Maximum Ratings

| Parameter   | Symbol       | Value      | Unit       |
|---|--------------|------------|------------|
| Collector-emitter voltage, $T_j \geq 25^\circ C$  | $V_{CE}$     | 600        | V          |
| DC collector current, limited by $T_{j,max}$<br>$T_C = 25^\circ C$ , value limited by bondwire<br>$T_C = 100^\circ C$ | $I_C$        | 26<br>23   | A          |
| Pulsed collector current, $t_p$ limited by $T_{j,max}$  | $I_{C,puls}$ | 45         |            |
| Turn off safe operating area, $V_{CE} = 600V$ , $T_j = 175^\circ C$ , $t_p = 1\mu s$                                  | -            | 45         |            |
| Gate-emitter voltage  | $V_{GE}$     | $\pm 20$   | V          |
| Short circuit withstand time <sup>2)</sup><br>$V_{GE} = 15V$ , $V_{CC} \leq 400V$ , $T_j \leq 150^\circ C$            | $t_{SC}$     | 5          | $\mu s$    |
| Power dissipation $T_C = 25^\circ C$  | $P_{tot}$    | 130        | W          |
| Operating junction temperature  | $T_j$        | -40...+175 |            |
| Storage temperature   | $T_{stg}$    | -55...+150 | $^\circ C$ |
| Soldering temperature<br>wavesoldering, 1.6 mm (0.063 in.) from case for 10s  |              | 260        |            |

<sup>1</sup> J-STD-020 and JESD-022

<sup>2)</sup> Allowed number of short circuits: <1000; time between short circuits: >1s.

### Thermal Resistance

| Parameter                                | Symbol     | Conditions | Max. Value | Unit |
|--|------------|------------|------------|------|
| <b>Characteristic</b>                    |            |            |            |      |
| IGBT thermal resistance, junction – case | $R_{thJC}$ |            | 1.15       | K/W  |
| Thermal resistance, junction – ambient   | $R_{thJA}$ |            | 62         |      |

### Electrical Characteristic, at $T_j = 25^\circ\text{C}$ , unless otherwise specified

| Parameter                            | Symbol        | Conditions   | Value |      |      | Unit     |
|--------------------------------------|---------------|--|-------|------|------|----------|
|                                      |               |  | min.  | Typ. | max. |          |
| <b>Static Characteristic</b>         |               |  |       |      |      |          |
| Collector-emitter breakdown voltage  | $V_{(BR)CES}$ | $V_{GE}=0V, I_C=0.2mA$   | 600   | -    | -    | V        |
| Collector-emitter saturation voltage | $V_{CE(sat)}$ | $V_{GE} = 15V, I_C=15A$<br>$T_j=25^\circ\text{C}$<br>$T_j=175^\circ\text{C}$       | -     | 1.5  | 2.05 |          |
| Gate-emitter threshold voltage       | $V_{GE(th)}$  | $I_C=210\mu A, V_{CE}=V_{GE}$  | 4.1   | 4.9  | 5.7  |          |
| Zero gate voltage collector current  | $I_{CES}$     | $V_{CE}=600V,$<br>$V_{GE}=0V$<br>$T_j=25^\circ\text{C}$<br>$T_j=175^\circ\text{C}$ | -     | -    | 40   | $\mu A$  |
| Gate-emitter leakage current         | $I_{GES}$     | $V_{CE}=0V, V_{GE}=20V$  | -     | -    | 100  |          |
| Transconductance                     | $g_{fs}$      | $V_{CE}=20V, I_C=15A$  | -     | 8.7  | -    | S        |
| Integrated gate resistor             | $R_{Gint}$    |  | -     |      |      | $\Omega$ |

### Dynamic Characteristic

|  |             |  |   |       |   |    |
|--|-------------|--|---|-------|---|----|
| Input capacitance  | $C_{iss}$   | $V_{CE}=25V,$  | - | 860   | - | pF |
| Output capacitance   | $C_{oss}$   | $V_{GE}=0V,$   | - | 55    | - |    |
| Reverse transfer capacitance                                   | $C_{riss}$  | $f=1MHz$   | - | 24    | - |    |
| Gate charge  | $Q_{Gate}$  | $V_{CC}=480V, I_C=15A$<br>$V_{GE}=15V$   | - | 87    | - | nC |
| Internal emitter inductance measured 5mm (0.197 in.) from case | $L_E$       |  | - | 7     | - | nH |
| Short circuit collector current <sup>1)</sup>                  | $I_{C(SC)}$ | $V_{GE}=15V, t_{SC}\leq 5\mu s$<br>$V_{CC} = 400V,$<br>$T_j = 150^\circ\text{C}$ | - | 137.5 | - | A  |

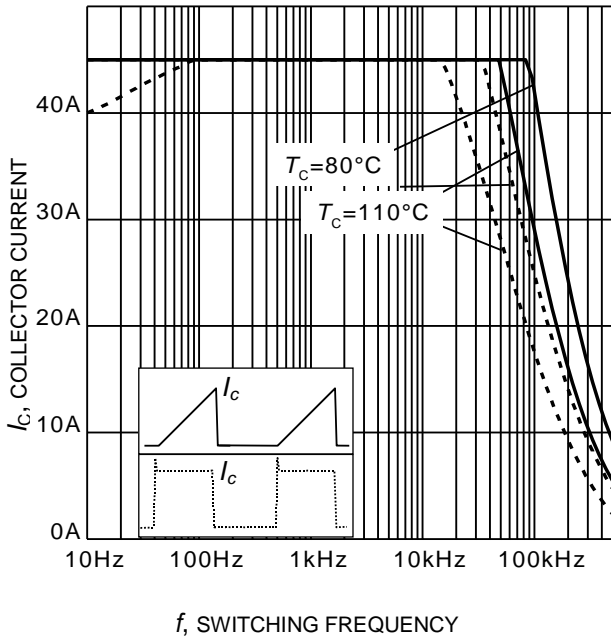
<sup>1)</sup> Allowed number of short circuits: <1000; time between short circuits: >1s.

### Switching Characteristic, Inductive Load, at $T_j=25\text{ °C}$

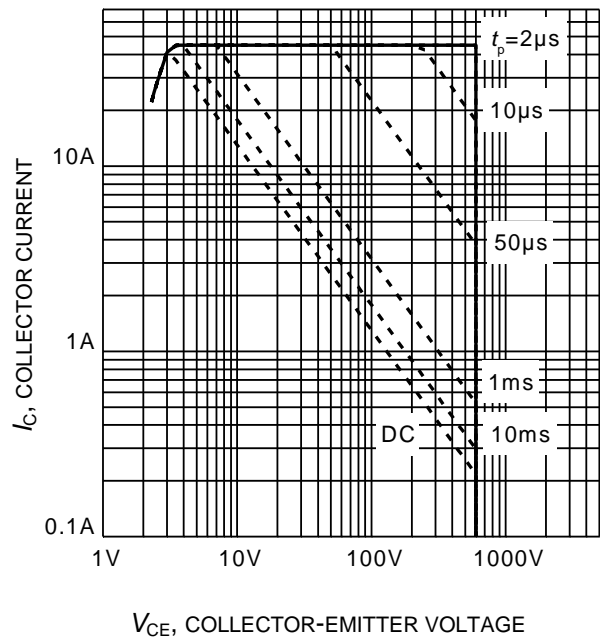
| Parameter                  | Symbol       | Conditions  | Value |      |      | Unit |
|----------------------------|--------------|---|-------|------|------|------|
|                            |              |   | min.  | Typ. | max. |      |
| <b>IGBT Characteristic</b> |              |   |       |      |      |      |
| Turn-on delay time         | $t_{d(on)}$  | $T_j=25\text{ °C}$ ,<br>$V_{CC}=400\text{V}$ , $I_C=15\text{A}$ ,<br>$V_{GE}=0/15\text{V}$ , $r_G=15\Omega$ ,<br>$L_\sigma=154\text{nH}$ , $C_\sigma=39\text{pF}$ | -     | 17   | -    | ns   |
| Rise time                  | $t_r$        |   | -     | 11   | -    |      |
| Turn-off delay time        | $t_{d(off)}$ |   | -     | 188  | -    |      |
| Fall time                  | $t_f$        |   | -     | 50   | -    |      |
| Turn-on energy             | $E_{on}$     | $L_\sigma$ , $C_\sigma$ from Fig. E<br>Energy losses include<br>"tail" and diode reverse<br>recovery.   | -     | 0.22 | -    | mJ   |
| Turn-off energy            | $E_{off}$    |   | -     | 0.35 | -    |      |
| Total switching energy     | $E_{ts}$     |   | -     | 0.57 | -    |      |

### Switching Characteristic, Inductive Load, at $T_j=175\text{ °C}$

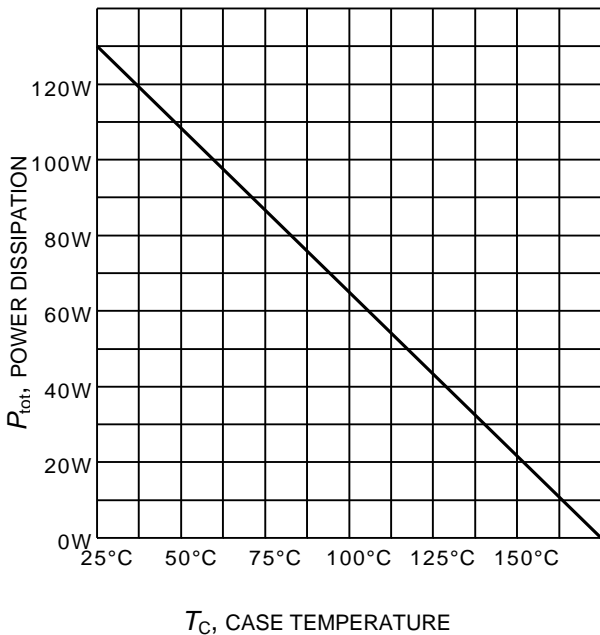
| Parameter                  | Symbol       | Conditions   | Value |      |      | Unit |
|----------------------------|--------------|--|-------|------|------|------|
|                            |              |  | min.  | Typ. | max. |      |
| <b>IGBT Characteristic</b> |              |  |       |      |      |      |
| Turn-on delay time         | $t_{d(on)}$  | $T_j=175\text{ °C}$ ,<br>$V_{CC}=400\text{V}$ , $I_C=15\text{A}$ ,<br>$V_{GE}=0/15\text{V}$ , $r_G=15\Omega$ ,<br>$L_\sigma=154\text{nH}$ , $C_\sigma=39\text{pF}$ | -     | 17   | -    | ns   |
| Rise time                  | $t_r$        |  | -     | 15   | -    |      |
| Turn-off delay time        | $t_{d(off)}$ |  | -     | 212  | -    |      |
| Fall time                  | $t_f$        |  | -     | 79   | -    |      |
| Turn-on energy             | $E_{on}$     | $L_\sigma$ , $C_\sigma$ from Fig. E<br>Energy losses include<br>"tail" and diode reverse<br>recovery.  | -     | 0.34 | -    | mJ   |
| Turn-off energy            | $E_{off}$    |  | -     | 0.47 | -    |      |
| Total switching energy     | $E_{ts}$     |  | -     | 0.81 | -    |      |



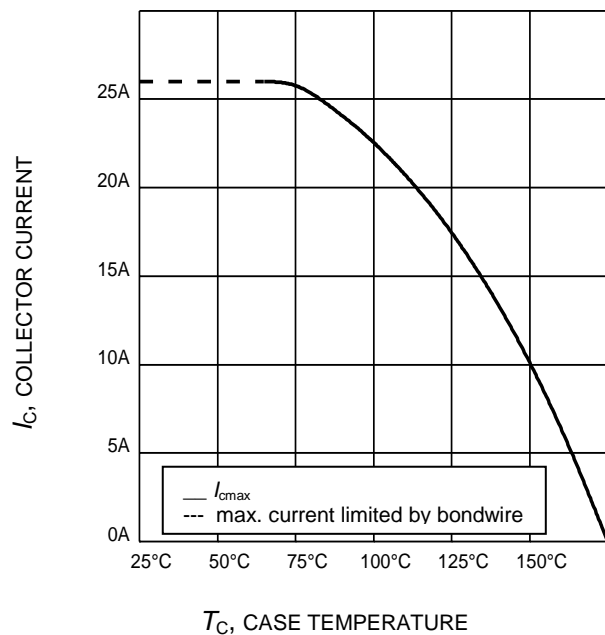
**Figure 1. Collector current as a function of switching frequency**  
 ( $T_j \leq 175^\circ\text{C}$ ,  $D = 0.5$ ,  $V_{CE} = 400\text{V}$ ,  $V_{GE} = 0/15\text{V}$ ,  $r_G = 15\Omega$ )



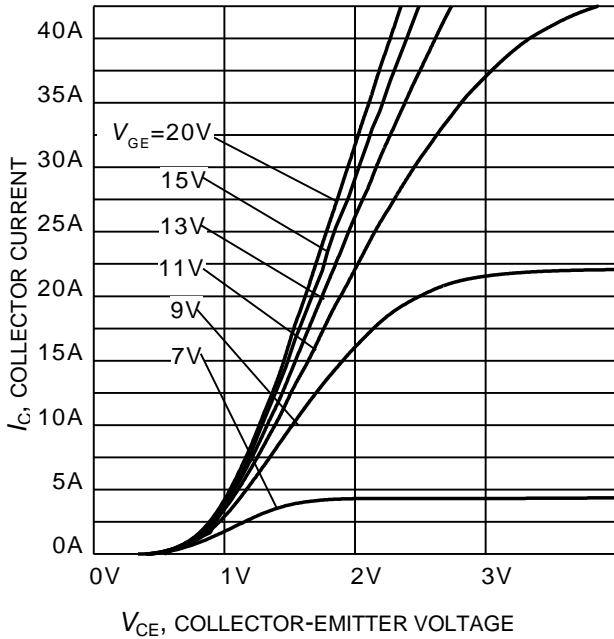
**Figure 2. Safe operating area**  
 ( $D = 0$ ,  $T_C = 25^\circ\text{C}$ ,  $T_j \leq 175^\circ\text{C}$ ;  $V_{GE} = 0/15\text{V}$ )



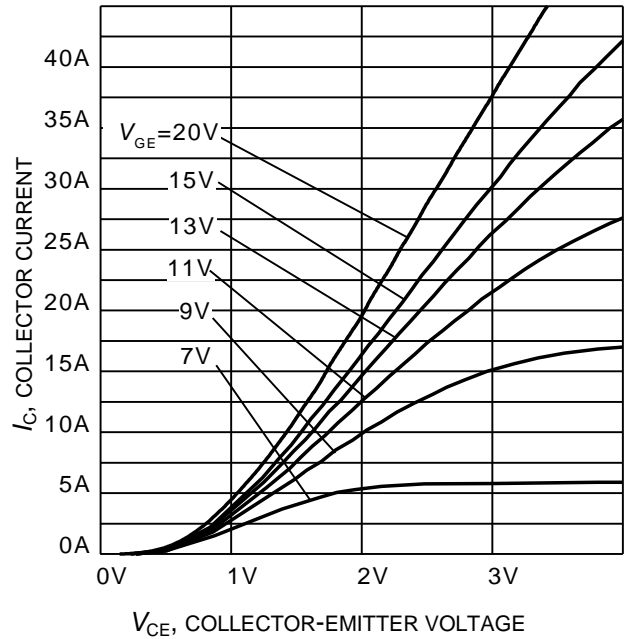
**Figure 3. Power dissipation as a function of case temperature**  
 ( $T_j \leq 175^\circ\text{C}$ )



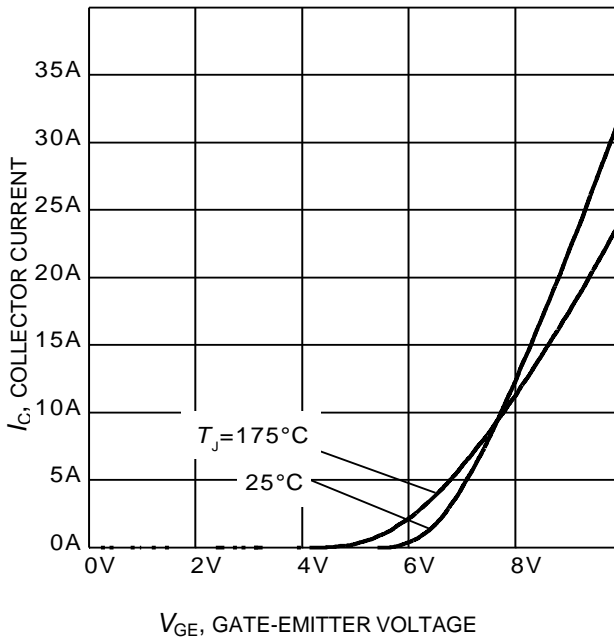
**Figure 4. Collector current as a function of case temperature**  
 ( $V_{GE} \geq 15\text{V}$ ,  $T_j \leq 175^\circ\text{C}$ )



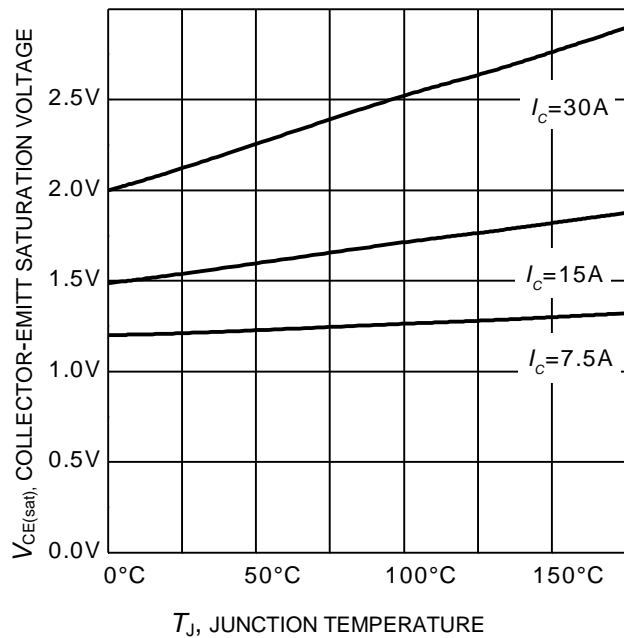
**Figure 5. Typical output characteristic**  
( $T_j = 25^\circ\text{C}$ )



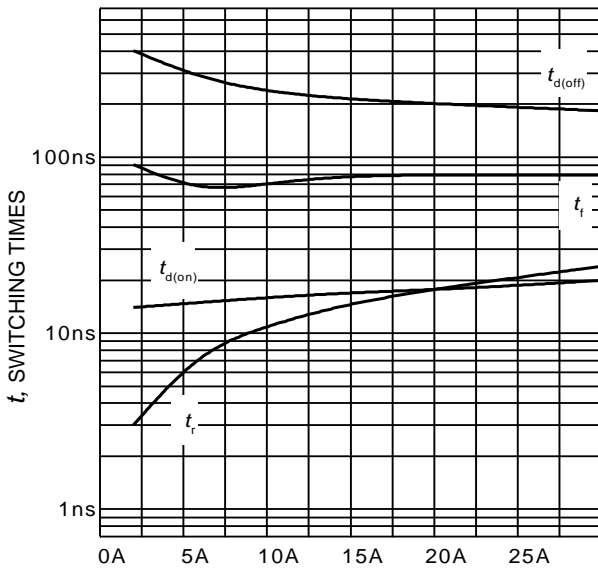
**Figure 6. Typical output characteristic**  
( $T_j = 175^\circ\text{C}$ )



**Figure 7. Typical transfer characteristic**  
( $V_{CE} = 20\text{V}$ )

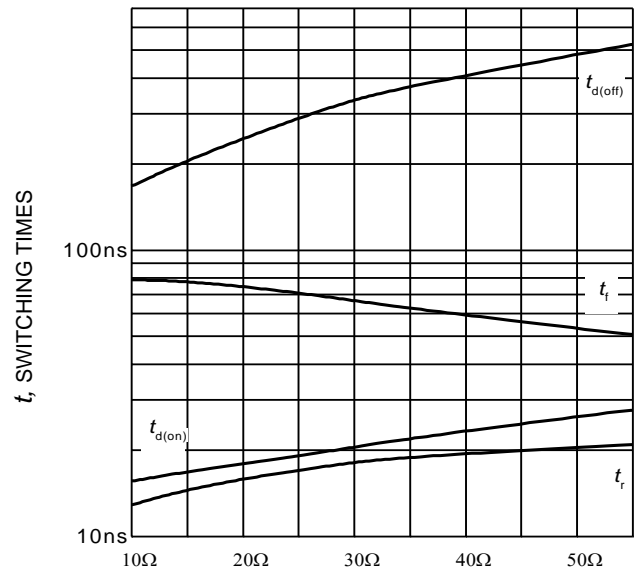


**Figure 8. Typical collector-emitter saturation voltage as a function of junction temperature**  
( $V_{GE} = 15\text{V}$ )



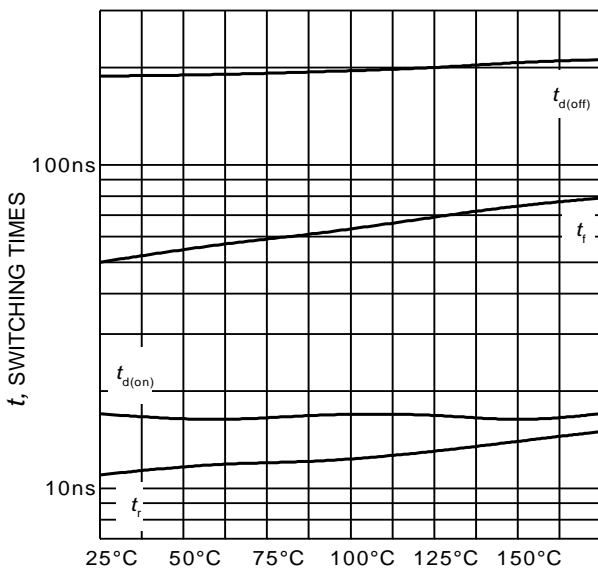
$I_C$ , COLLECTOR CURRENT

**Figure 9. Typical switching times as a function of collector current**  
(inductive load,  $T_J=175^\circ\text{C}$ ,  
 $V_{CE} = 400\text{V}$ ,  $V_{GE} = 0/15\text{V}$ ,  $r_G = 15\Omega$ ,  
Dynamic test circuit in Figure E)



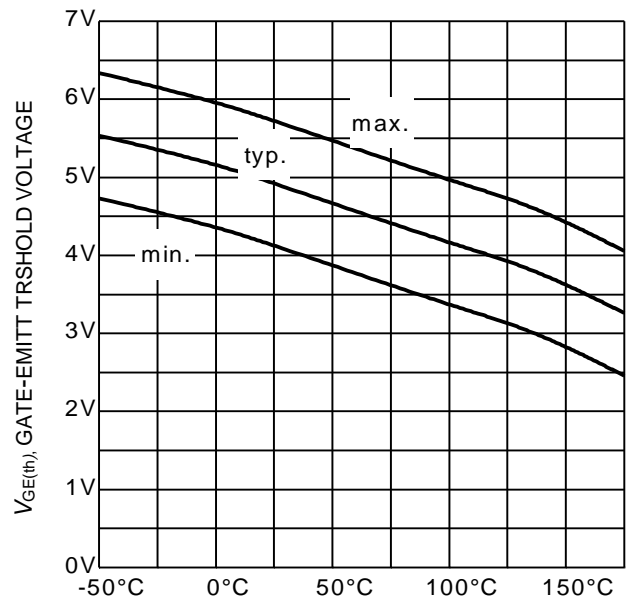
$R_G$ , GATE RESISTOR

**Figure 10. Typical switching times as a function of gate resistor**  
(inductive load,  $T_J = 175^\circ\text{C}$ ,  
 $V_{CE} = 400\text{V}$ ,  $V_{GE} = 0/15\text{V}$ ,  $I_C = 15\text{A}$ ,  
Dynamic test circuit in Figure E)



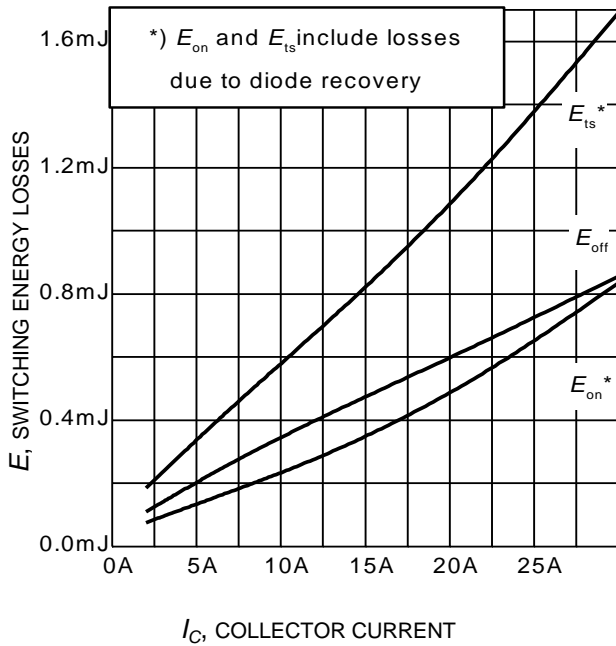
$T_J$ , JUNCTION TEMPERATURE

**Figure 11. Typical switching times as a function of junction temperature**  
(inductive load,  $V_{CE} = 400\text{V}$ ,  
 $V_{GE} = 0/15\text{V}$ ,  $I_C = 15\text{A}$ ,  $r_G=15\Omega$ ,  
Dynamic test circuit in Figure E)

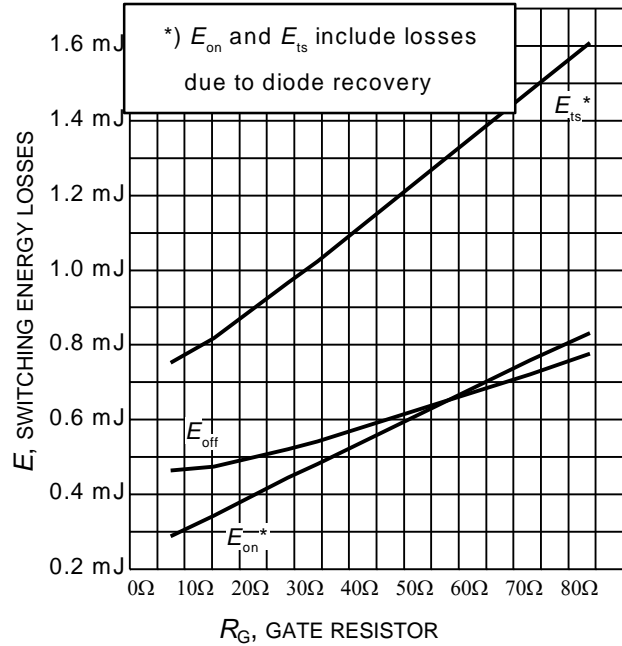


$T_J$ , JUNCTION TEMPERATURE

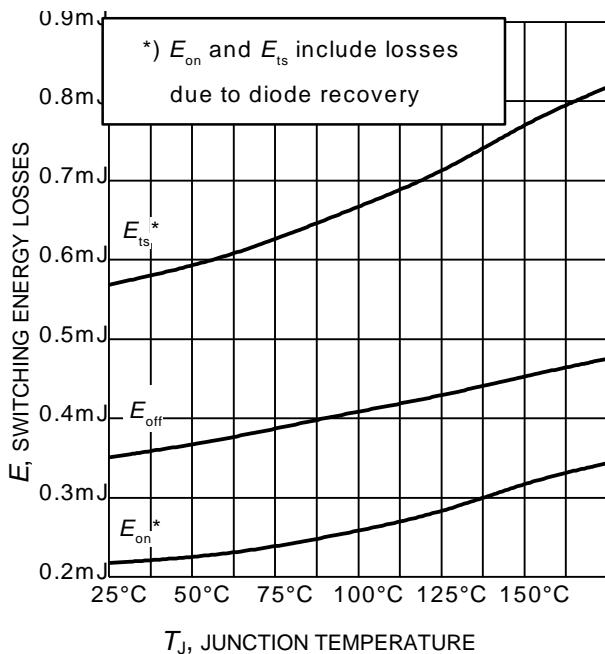
**Figure 12. Gate-emitter threshold voltage as a function of junction temperature**  
( $I_C = 0.21\text{mA}$ )



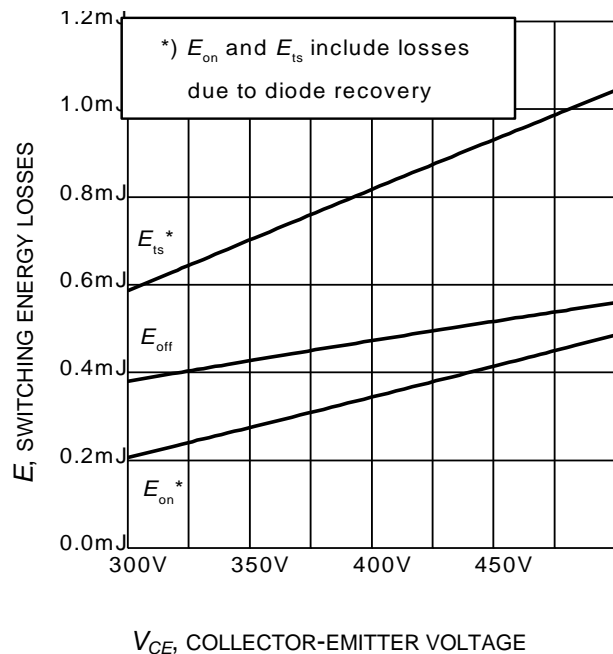
**Figure 13. Typical switching energy losses as a function of collector current**  
(inductive load,  $T_J = 175^\circ\text{C}$ ,  $V_{CE} = 400\text{V}$ ,  $V_{GE} = 0/15\text{V}$ ,  $r_G = 15\Omega$ , Dynamic test circuit in Figure E)



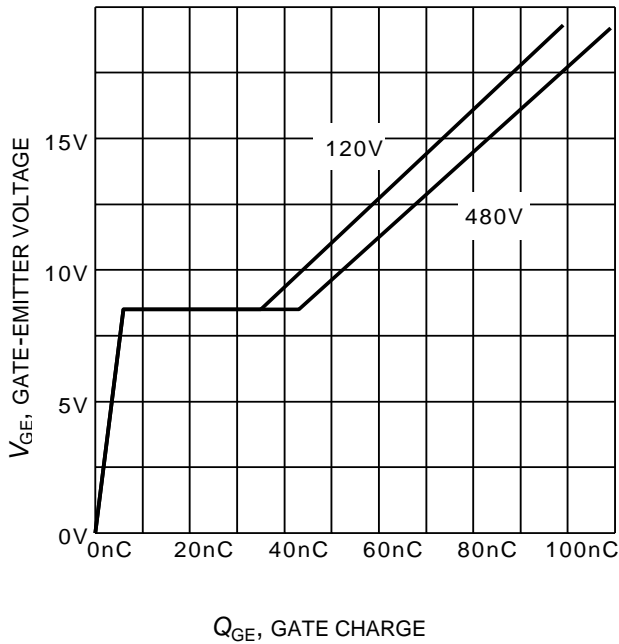
**Figure 14. Typical switching energy losses as a function of gate resistor**  
(inductive load,  $T_J = 175^\circ\text{C}$ ,  $V_{CE} = 400\text{V}$ ,  $V_{GE} = 0/15\text{V}$ ,  $I_C = 15\text{A}$ , Dynamic test circuit in Figure E)



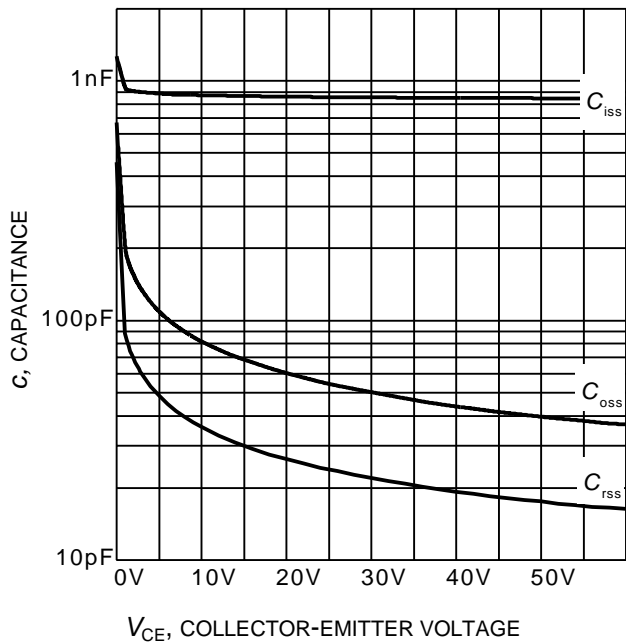
**Figure 15. Typical switching energy losses as a function of junction temperature**  
(inductive load,  $V_{CE} = 400\text{V}$ ,  $V_{GE} = 0/15\text{V}$ ,  $I_C = 15\text{A}$ ,  $r_G = 15\Omega$ , Dynamic test circuit in Figure E)



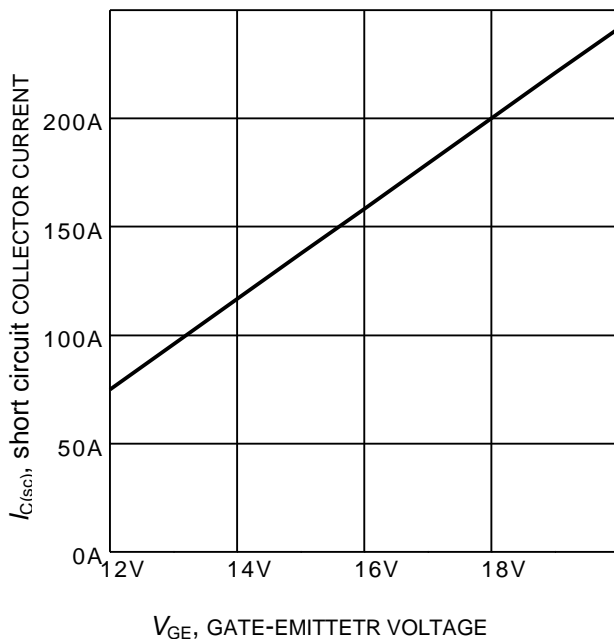
**Figure 16. Typical switching energy losses as a function of collector emitter voltage**  
(inductive load,  $T_J = 175^\circ\text{C}$ ,  $V_{GE} = 0/15\text{V}$ ,  $I_C = 15\text{A}$ ,  $r_G = 15\Omega$ , Dynamic test circuit in Figure E)



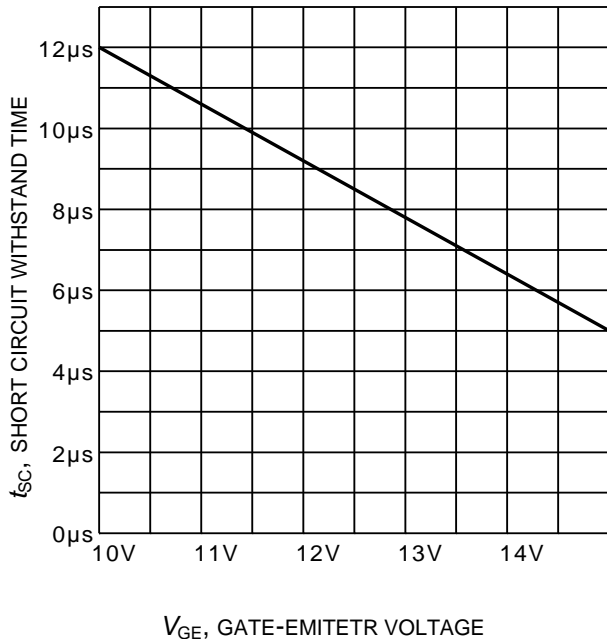
**Figure 17. Typical gate charge**  
( $I_C=15\text{ A}$ )



**Figure 18. Typical capacitance as a function of collector-emitter voltage**  
( $V_{GE}=0\text{V}$ ,  $f = 1\text{ MHz}$ )

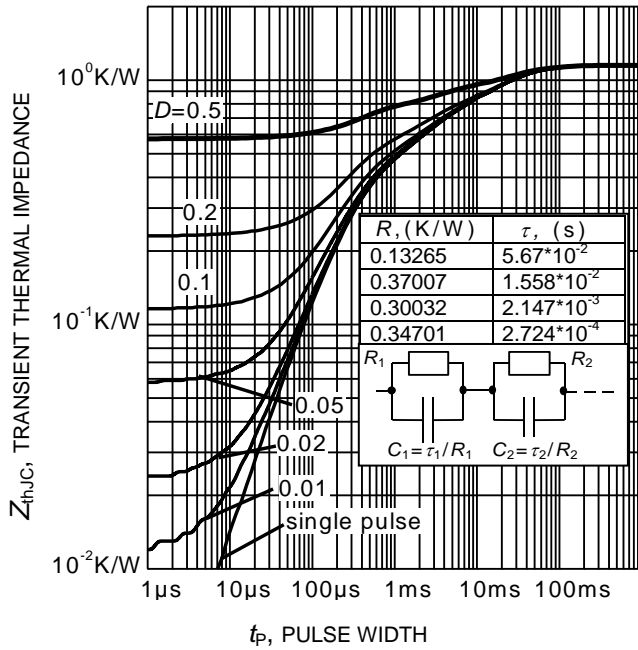


**Figure 19. Typical short circuit collector current as a function of gate-emitter voltage**  
( $V_{CE} \leq 400\text{V}$ ,  $T_J \leq 150^\circ\text{C}$ )



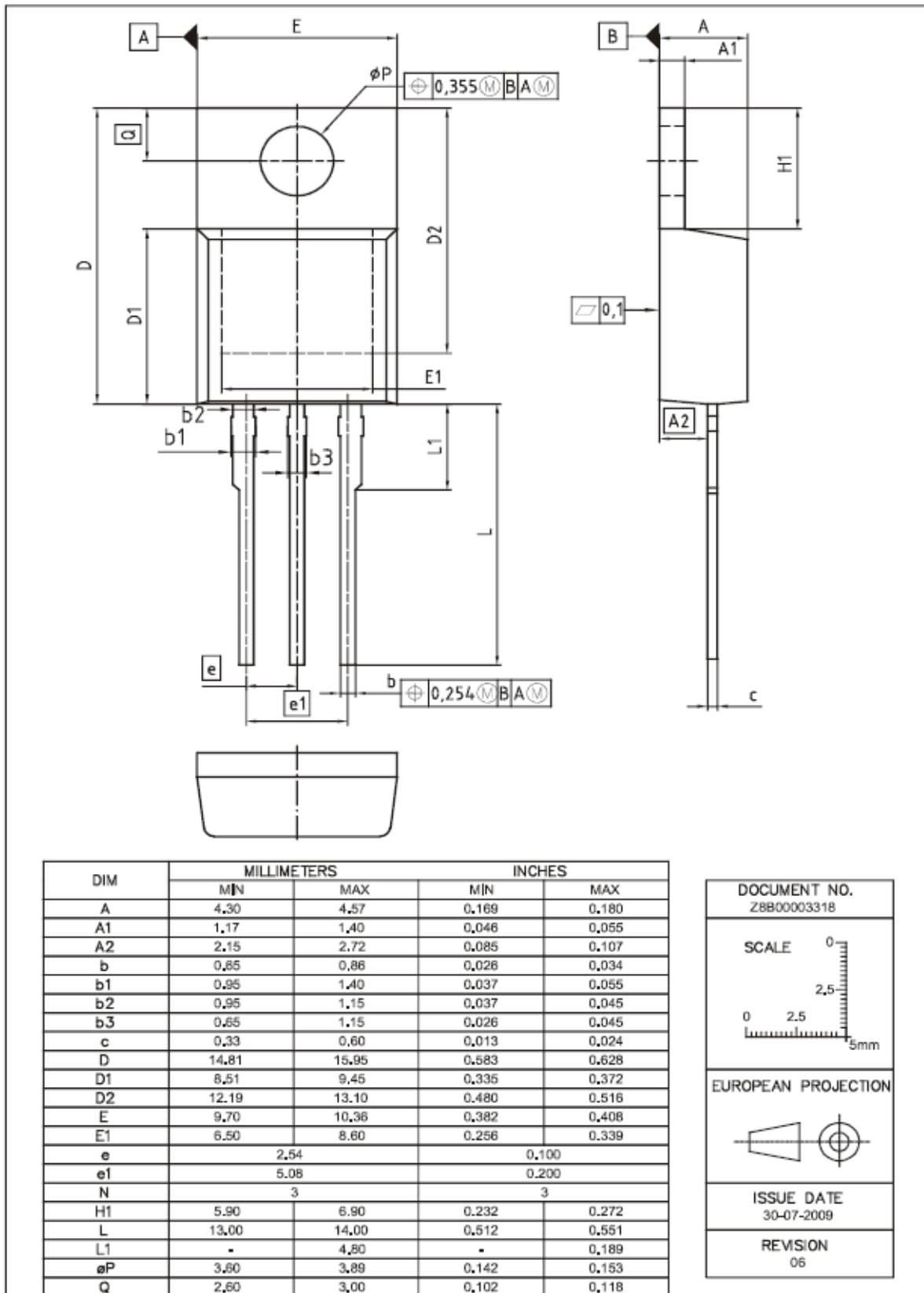
**Figure 20. Short circuit withstand time as a function of gate-emitter voltage**  
( $V_{CE}=400\text{V}$ , start at  $T_J=25^\circ\text{C}$ ,  $T_{Jmax}<150^\circ\text{C}$ )

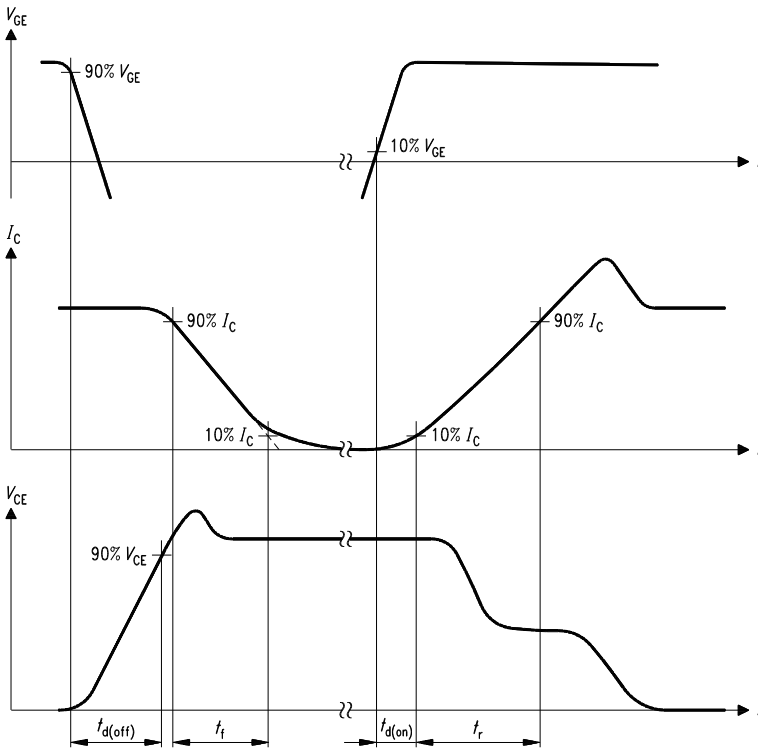




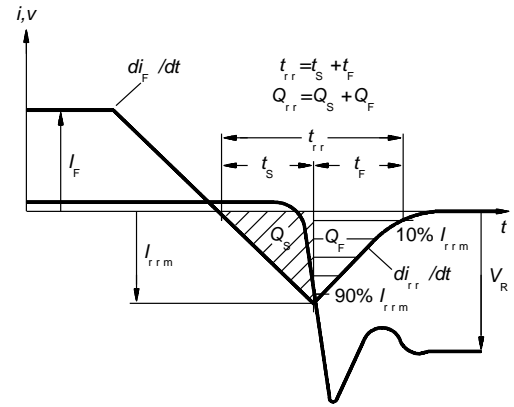
**Figure 21. IGBT transient thermal impedance**  
 $(D = t_p / T)$

### PG-TO220-3

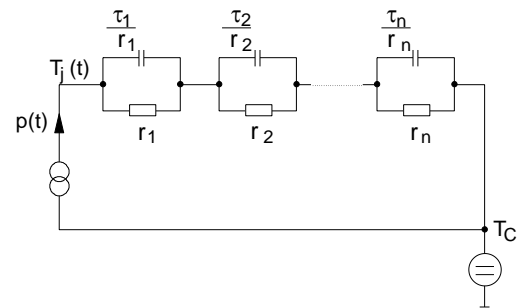




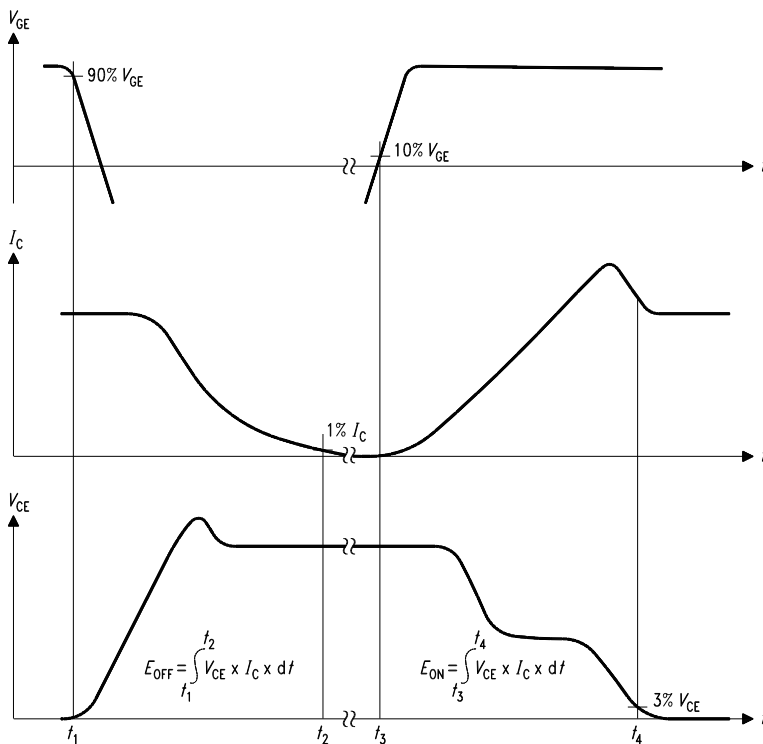
**Figure A. Definition of switching times**



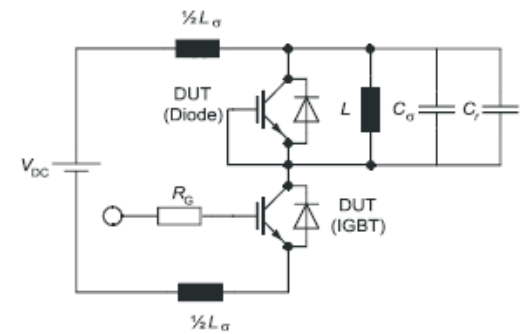
**Figure C. Definition of diodes switching characteristics**



**Figure D. Thermal equivalent circuit**



**Figure B. Definition of switching losses**



**Figure E. Dynamic test circuit**  
Parasitic inductance  $L_\sigma$ ,  
Parasitic capacitor  $C_\sigma$ ,  
Relief capacitor  $C_r$   
(only for ZVT switching)

**Published by**  
**Infineon Technologies AG**  
**81726 Munich, Germany**  
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